**Product data sheet** 

### 1. Product profile

### 1.1 General description

N-channel enhancement mode Field-Effect Transistor (FET) in a leadless medium power DFN2020MD-6 (SOT1220) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

### 1.2 Features and benefits

- Trench MOSFET technology
- Very fast switching
- Small and leadless ultra thin SMD plastic package: 2 x 2 x 0.65 mm
- Exposed drain pad for excellent thermal conduction
- Tin-plated 100 % solderable side pads for optical solder inspection

### 1.3 Applications

- Charging switch for portable devices
- DC-to-DC converters

- Power management in battery-driven portables
- Hard disk and computing power management

### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>j</sub> = 25 °C		-	-	30	V
$V_{GS}$	gate-source voltage			-20	-	20	V
I <sub>D</sub>	drain current	$V_{GS} = 10 \text{ V}; T_{amb} = 25 \text{ °C}; t \le 5 \text{ s}$	<u>[1]</u>	-	-	13	Α
Static characte	eristics						
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 9 \text{ A}; T_j = 25 ^{\circ}\text{C}$		-	12	14.5	mΩ

<sup>[1]</sup> Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 6 cm<sup>2</sup>.





# 2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	D	drain		
2	D	drain	1 6	D
3	G	gate	2 7 5	G (EX)
4	S	source		<u></u>
5	D	drain	3 8 4	\$ 017aaa253
6	D	drain	Transparent top view	U17888253
7	D	drain	SOT1220 (DFN2020MD-6)	
8	S	source		

# 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PMPB11EN	DFN2020MD-6	plastic thermal enhanced ultra thin small outline package; no leads; 6 terminals	SOT1220

# 4. Marking

Table 4. Marking codes

Type number	Marking code
PMPB11EN	1C

### 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>j</sub> = 25 °C		-	30	V
$V_{GS}$	gate-source voltage			-20	20	V
I <sub>D</sub>	drain current	$V_{GS} = 10 \text{ V; } T_{amb} = 25 \text{ °C; } t \le 5 \text{ s}$	<u>[1]</u>	-	13	Α
		V <sub>GS</sub> = 10 V; T <sub>amb</sub> = 25 °C	<u>[1]</u>	-	9	Α
		V <sub>GS</sub> = 10 V; T <sub>amb</sub> = 100 °C	<u>[1]</u>	-	5.7	Α
I <sub>DM</sub>	peak drain current	$T_{amb} = 25  ^{\circ}C$ ; single pulse; $t_p \le 10  \mu s$		-	34	Α
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = 25 °C	<u>[1]</u>	-	1.7	W
		T <sub>amb</sub> = 25 °C; t ≤ 5 s	<u>[1]</u>	-	3.5	W
		T <sub>sp</sub> = 25 °C		-	12.5	W
Tj	junction temperature			-55	150	°C
T <sub>amb</sub>	ambient temperature			-55	150	°C
T <sub>stg</sub>	storage temperature			-65	150	°C
Source-drain	n diode					
Is	source current	T <sub>amb</sub> = 25 °C	<u>[1]</u>	-	2.2	Α

[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 6 cm<sup>2</sup>.

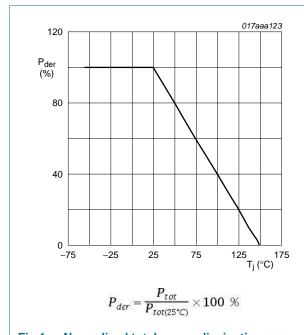


Fig 1. Normalized total power dissipation as a function of junction temperature

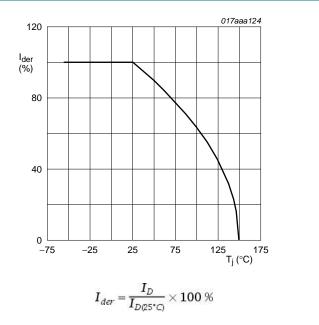


Fig 2. Normalized continuous drain current as a function of junction temperature

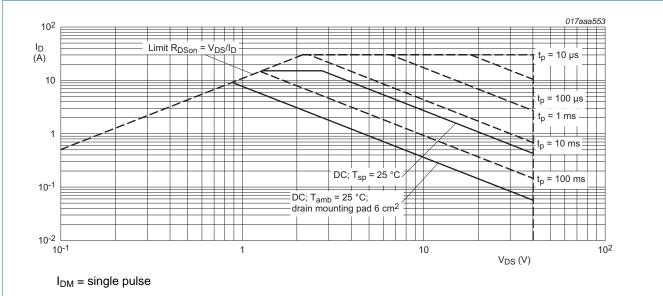


Fig 3. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source voltage

### 6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
fr	thermal resistance	in free air	<u>[1]</u>	-	235	270	K/W
	from junction to ambient		[2]	-	67	74	K/W
	ambient		[3]	-	33	36	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point			-	5	10	K/W

<sup>[1]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

<sup>[2]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 6 cm<sup>2</sup>.

<sup>[3]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 6 cm<sup>2</sup>, t ≤ 5 s

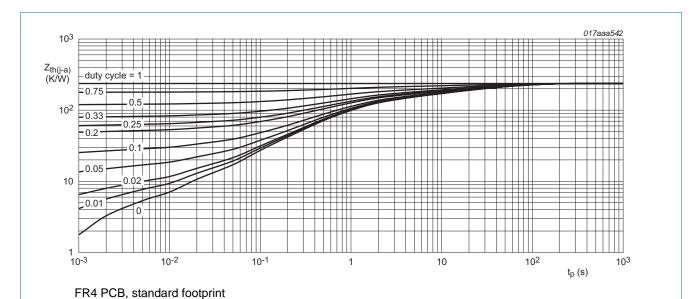


Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

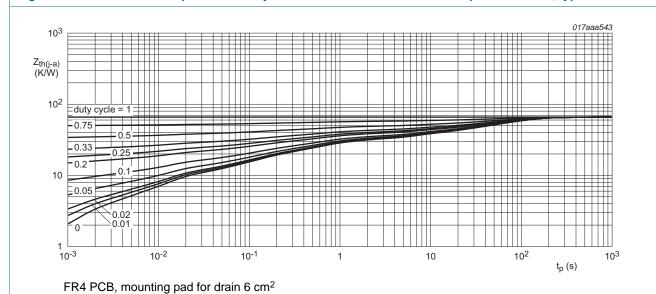


Fig 5. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

## 7. Characteristics

Table 7. Characteristics

Table 7.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	30	-	-	V
$V_{GSth}$	gate-source threshold voltage	$I_D = 250 \mu A; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	1	1.5	2	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	1	μΑ
		$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ °C}$	-	-	20	μΑ
$I_{GSS}$	gate leakage current	$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	100	nΑ
		$V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	100	nΑ
R <sub>DSon</sub>	drain-source on-state	$V_{GS} = 10 \text{ V}; I_D = 9 \text{ A}; T_j = 25 \text{ °C}$	-	12	14.5	mΩ
	resistance	$V_{GS} = 10 \text{ V}; I_D = 9 \text{ A}; T_j = 150 ^{\circ}\text{C}$	-	18	20.5	mΩ
		$V_{GS} = 4.5 \text{ V}; I_D = 3.7 \text{ A}; T_j = 25 \text{ °C}$	-	14	16.5	mΩ
9 <sub>fs</sub>	forward transconductance	$V_{DS} = 10 \text{ V}; I_D = 9 \text{ A}; T_j = 25 ^{\circ}\text{C}$	-	20	-	S
$R_G$	gate resistance	f = 1 MHz	-	1.6	-	Ω
Dynamic	characteristics					
$Q_{G(tot)}$	total gate charge	$V_{DS} = 15 \text{ V}; I_D = 6 \text{ A}; V_{GS} = 10 \text{ V};$	-	13.7	20.6	nC
$Q_{GS}$	gate-source charge	T <sub>j</sub> = 25 °C	-	1.73	-	nC
$Q_{GD}$	gate-drain charge		-	1.71	-	nC
C <sub>iss</sub>	input capacitance	$V_{DS} = 10 \text{ V}; f = 1 \text{ MHz}; V_{GS} = 0 \text{ V};$	-	840	-	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C	-	155	-	pF
C <sub>rss</sub>	reverse transfer capacitance		-	65	-	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 15 \text{ V}; I_D = 5 \text{ A}; V_{GS} = 4.5 \text{ V};$	-	9	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 6 \Omega; T_j = 25 °C$	-	10	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	17	-	ns
t <sub>f</sub>	fall time		-	9	-	ns
Source-d	rain diode					
$V_{SD}$	source-drain voltage	I <sub>S</sub> = 2.2 A; V <sub>GS</sub> = 0 V; T <sub>i</sub> = 25 °C	-	0.8	1.2	V

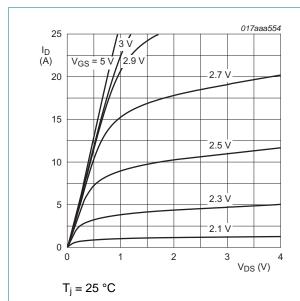


Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values

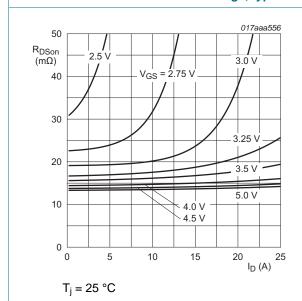
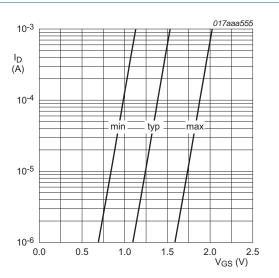
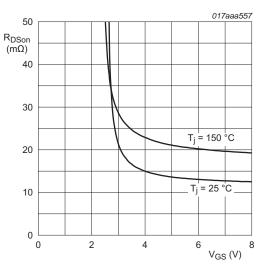


Fig 8. Drain-source on-state resistance as a function of drain current; typical values



 $T_i = 25 \, ^{\circ}C; \, V_{DS} = 5 \, V$ 

Fig 7. Sub-threshold drain current as a function of gate-source voltage



 $I_D = 8 A$ 

Fig 9. Drain-source on-state resistance as a function of gate-source voltage; typical values

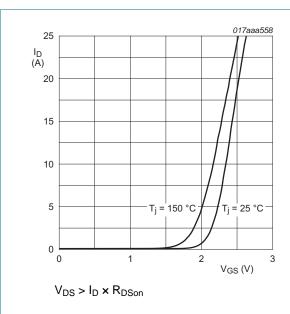


Fig 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values

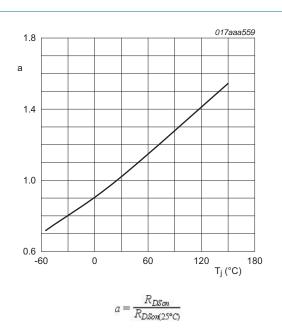


Fig 11. Normalized drain-source on-state resistance as a function of junction temperature; typical values

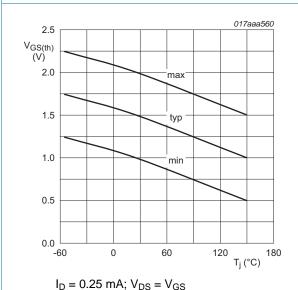
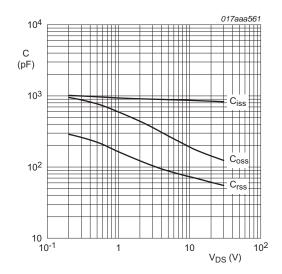
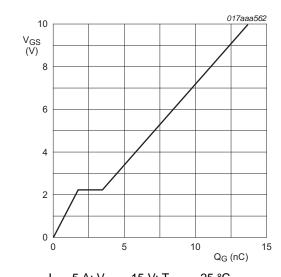


Fig 12. Gate-source threshold voltage as a function of junction temperature



 $f = 1 MHz; V_{GS} = 0 V$ 

Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

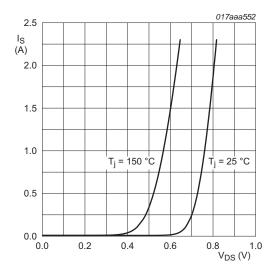


V<sub>GS</sub>(pl)
V<sub>GS</sub>(th)
V<sub>GS</sub>
Q<sub>GS1</sub>
Q<sub>GS2</sub>
Q<sub>G</sub>(tot)
017aaa137

 $I_D = 5 \text{ A}; V_{DS} = 15 \text{ V}; T_{amb} = 25 \text{ }^{\circ}\text{C}$ 

Fig 14. Gate-source voltage as a function of gate charge; typical values

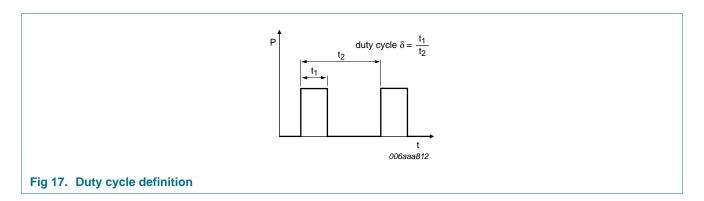
Fig 15. Gate charge waveform definitions



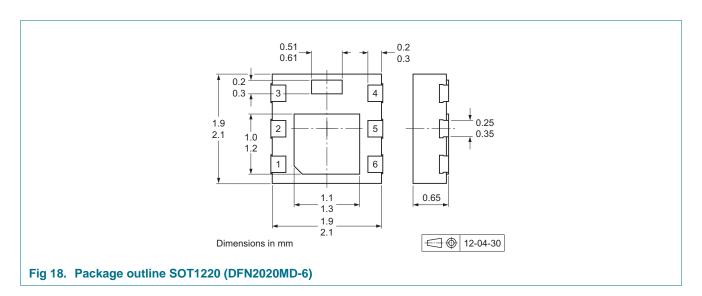
 $V_{GS} = 0 V$ 

Fig 16. Source current as a function of source-drain voltage; typical values

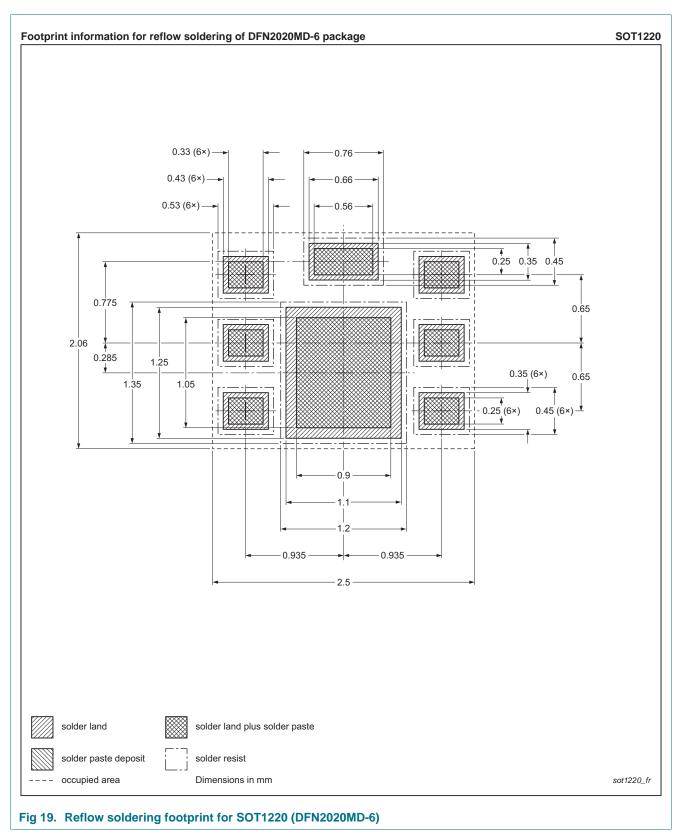
### 8. Test information



# 9. Package outline



## 10. Soldering





# 11. Revision history

#### Table 8. **Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes
PMPB11EN v.1	20120516	Product data sheet	-	-

### 12. Legal information

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Document status[1] [2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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PMPB11EN

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#### 30 V N-channel Trench MOSFET

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# PMPB11EN

### **30 V N-channel Trench MOSFET**

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